

## MOS FIELD EFFECT TRANSISTOR 2SK3325

### SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

### **DESCRIPTION**

The 2SK3325 is N-Channel DMOS FET device that features a low gate charge and excellent switching characteristics, and designed for high voltage applications such as switching power supply, AC adapter.

### **FEATURES**

- · Low gate charge:
  - $Q_G = 22 \text{ nC TYP.}$  (VDD = 400 V, VGS = 10 V, ID = 10 A)
- Gate voltage rating: ±30 V
- Low on-state resistance

 $R_{DS(on)} = 0.85 \Omega MAX. (V_{GS} = 10 V, I_{D} = 5.0 A)$ 

- · Avalanche capability ratings
- TO-220AB, TO-262, TO-263 package

### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vgs = 0 V)             | Voss     | 500         | V  |
|---|----------|-------------|----|
| Gate to Source Voltage (Vps = 0 V)              | VGSS(AC) | ±30         | V  |
| Drain Current (DC)                              | ID(DC)   | ±10         | Α  |
| Drain Current (pulse) Note1                     | D(pulse) | ±40         | Α  |
| Total Power Dissipation (Tc = 25°C)             | PT       | 85          | W  |
| Total Power Dissipation (T <sub>A</sub> = 25°C) | PT       | 1.5         | W  |
| Channel Temperature                             | Tch      | 150         | °C |
| Storage Temperature                             | Tstg     | -55 to +150 | °C |
| Single Avalanche Current Note2                  | las      | 10          | Α  |
| Single Avalanche Energy Note2                   | Eas      | 10.7        | mJ |

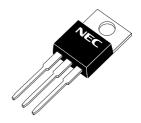
**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1 %

2. Starting T<sub>ch</sub> = 25 °C, V<sub>DD</sub> = 150 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20 V  $\rightarrow$  0 V

### ORDERING INFORMATION

| PART NUMBER | PACKAGE  |  |  |
|-------------|----------|--|--|
| 2SK3325     | TO-220AB |  |  |
| 2SK3325-S   | TO-262   |  |  |
| 2SK3325-ZJ  | TO-263   |  |  |

(TO-220AB)



(TO-262)



(TO-263)



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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

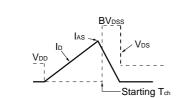


### **ELECTRICAL CHARACTERISTICS (TA = 25 °C)**

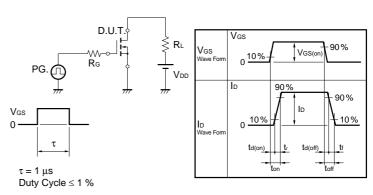
| CHARACTERISTICS                     | SYMBOL               | TEST CONDITIONS   | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Drain Leakage Current               | IDSS                 | V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V  |      |      | 100  | μΑ   |
| Gate to Source Leakage Current      | Igss                 | $V_{GS} = \pm 30  V,  V_{DS} = 0  V$  |      |      | ±100 | nA   |
| Gate to Source Cut-off Voltage      | V <sub>GS(off)</sub> | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA   | 2.5  |      | 3.5  | V    |
| Forward Transfer Admittance         | yfs                  | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 5.0 A  | 2.0  | 4.0  |      | S    |
| Drain to Source On-state Resistance | RDS(on)              | Ves = 10 V, ID = 5.0 A  |      | 0.68 | 0.85 | Ω    |
| Input Capacitance                   | Ciss                 | Vps = 10 V, Vgs = 0 V, f = 1 MHz  |      | 1200 |      | pF   |
| Output Capacitance                  | Coss                 |   |      | 190  |      | pF   |
| Reverse Transfer Capacitance        | Crss                 |   |      | 10   |      | pF   |
| Turn-on Delay Time                  | td(on)               | $V_{DD} = 150  V,  I_D = 5.0  A,  V_{GS(on)} = 10  V,$                                    |      | 21   |      | ns   |
| Rise Time                           | tr                   | $R_G = 10 \Omega$ , $R_L = 60 \Omega$   |      | 11   |      | ns   |
| Turn-off Delay Time                 | t <sub>d(off)</sub>  |   |      | 40   |      | ns   |
| Fall Time                           | t <sub>f</sub>       |   |      | 9.5  |      | ns   |
| Total Gate Charge                   | Q <sub>G</sub>       | V <sub>DD</sub> = 400 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A                    |      | 22   |      | nC   |
| Gate to Source Charge               | Qgs                  |   |      | 6.5  |      | nC   |
| Gate to Drain Charge                | Q <sub>GD</sub>      |   |      | 7.5  |      | nC   |
| Body Diode Forward Voltage          | V <sub>F</sub> (S-D) | IF = 10 A, VGS = 0 V  |      | 1.0  |      | V    |
| Reverse Recovery Time               | trr                  | $I_F = 10 \text{ A}, \text{ Vgs} = 0 \text{ V}, \text{ di/dt} = 50 \text{ A}/\mu\text{s}$ |      | 0.5  |      | μs   |
| Reverse Recovery Charge             | Qrr                  |   |      | 2.6  |      | μC   |

### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \, \Omega \\ \text{Vgs} = 20 \, \rightarrow \, 0 \, \text{V} \end{array} \begin{array}{c} \text{D.U.T.} \\ \text{S} \\ \text{S} \\ \text{S} \\ \text{O} \end{array} \begin{array}{c} \text{D.U.T.} \\ \text{In} \\ \text{In} \\ \text{In} \end{array}$



### **TEST CIRCUIT 2 SWITCHING TIME**



### **TEST CIRCUIT 3 GATE CHARGE**



### TYPICAL CHARACTERISTICS(TA = 25 °C)

Figure 1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA

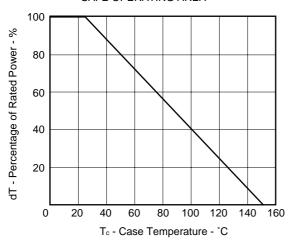


Figure3. FORWARD BIAS SAFE OPERATING AREA

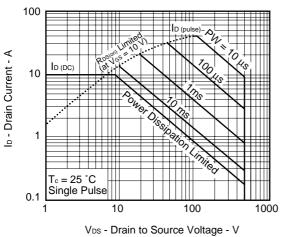


Figure5. DRAIN CURRENT vs.
GATE TO SOURCE VOLTAGE

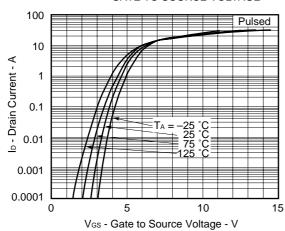


Figure 2. TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

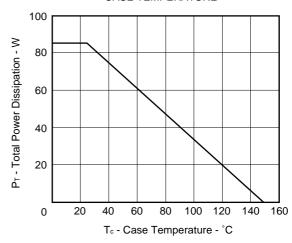
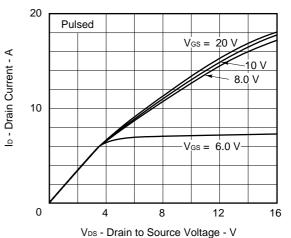


Figure4. DRAIN CURRENT vs.
DRAIN TO SOURCE VOLTAGE



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### Figure 6. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

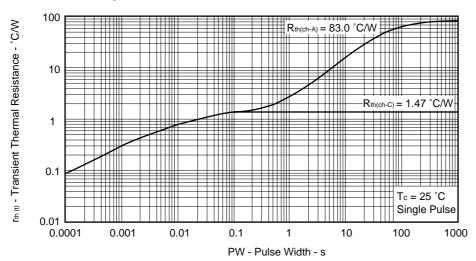


Figure7. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

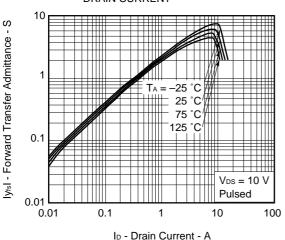


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

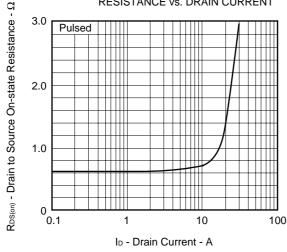


Figure8. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

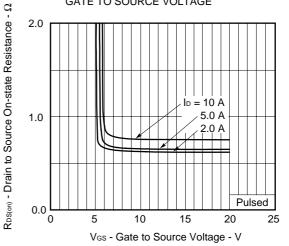


Figure 10. GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

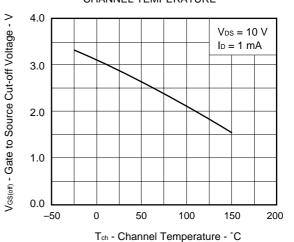




Figure 13. CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

Tch - Channel Temperature - °C

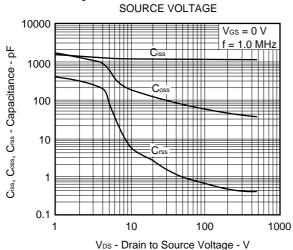


Figure 15. REVERSE RECOVERY TIME vs. DRAIN CURRENT

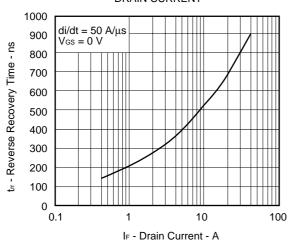
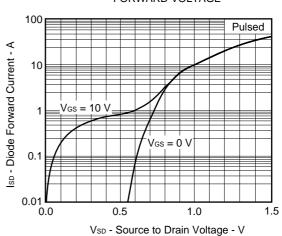


Figure 12. SOURCE TO DRAIN DIODE FORWARD VOLTAGE



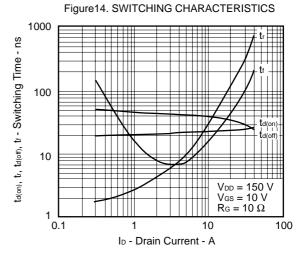


Figure 16. DYNAMIC INPUT/OUTPUT CHARACTERISTICS

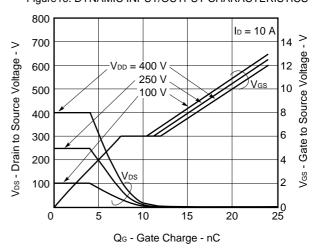


Figure 17. SINGLE AVALANCHE ENERGY vs STARTING CHANNEL TEMPERATURE

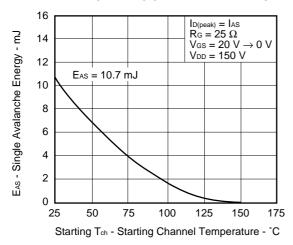
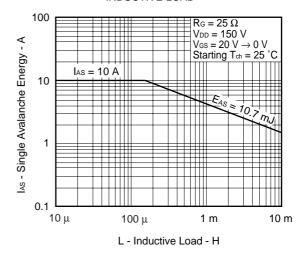


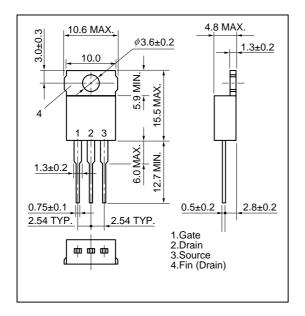
Figure 18. SINGLE AVALANCHE ENERGY vs INDUCTIVE LOAD



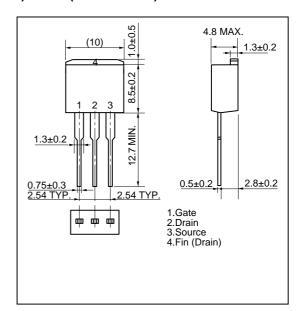


### PACKAGE DRAWINGS (Unit: mm)

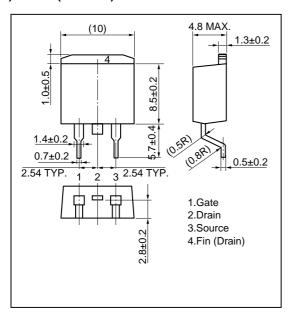
### 1)TO-220AB (MP-25)



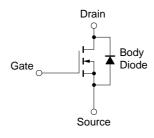
### 2)TO-262 (MP-25 Fin Cut)



### 3)TO-263 (MP-25ZJ)



### **EQUIVALENT CIRCUIT**



**Remark** Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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